

This article was downloaded by:

On: 30 January 2011

Access details: *Access Details: Free Access*

Publisher *Taylor & Francis*

Informa Ltd Registered in England and Wales Registered Number: 1072954 Registered office: Mortimer House, 37-41 Mortimer Street, London W1T 3JH, UK



## **Spectroscopy Letters**

Publication details, including instructions for authors and subscription information:

<http://www.informaworld.com/smpp/title~content=t713597299>

### **ENHANCED PHOTOLUMINESCENCE OF Eu(III)-ANCHORED POROUS ANODIC ALUMINA FILM**

Yan-li Shi<sup>a</sup>; Xiao-gang Zhang<sup>a</sup>; Hu-lin Li<sup>a</sup>

<sup>a</sup> Department of Chemistry, Lanzhou University, Lanzhou, P.R. China

Online publication date: 31 July 2001

**To cite this Article** Shi, Yan-li , Zhang, Xiao-gang and Li, Hu-lin(2001) 'ENHANCED PHOTOLUMINESCENCE OF Eu(III)-ANCHORED POROUS ANODIC ALUMINA FILM', *Spectroscopy Letters*, 34: 4, 419 — 426

**To link to this Article:** DOI: 10.1081/SL-100105088

**URL:** <http://dx.doi.org/10.1081/SL-100105088>

**PLEASE SCROLL DOWN FOR ARTICLE**

Full terms and conditions of use: <http://www.informaworld.com/terms-and-conditions-of-access.pdf>

This article may be used for research, teaching and private study purposes. Any substantial or systematic reproduction, re-distribution, re-selling, loan or sub-licensing, systematic supply or distribution in any form to anyone is expressly forbidden.

The publisher does not give any warranty express or implied or make any representation that the contents will be complete or accurate or up to date. The accuracy of any instructions, formulae and drug doses should be independently verified with primary sources. The publisher shall not be liable for any loss, actions, claims, proceedings, demand or costs or damages whatsoever or howsoever caused arising directly or indirectly in connection with or arising out of the use of this material.

## ENHANCED PHOTOLUMINESCENCE OF Eu(III)-ANCHORED POROUS ANODIC ALUMINA FILM

Yan-li Shi, Xiao-gang Zhang, and Hu-lin Li\*

Department of Chemistry, Lanzhou University,  
Lanzhou 730000, P.R. China

### ABSTRACT

We report here the enhanced luminescence of Eu(III)-anchored porous anodic alumina prepared by self-assembling Eu(III) acetylacetonate, and investigate the luminescence mechanisms. Porous anodic alumina can emit visible light due to a lot of oxygen vacancies formed in the anodic oxidation. The existence of oxygen vacancies resulted in  $e^-h^+$  pairs when excited. Eu(II) exists stably by forming  $Eu^{2+}$ -hole complexes. The enhanced luminescence of Eu(III)-anchored porous anodic alumina is attributed to the complex luminescence of  $e^-h^+$  through luminescence center  $Eu^{2+}$ .

*Key Words:* Porous anodic alumina; Enhanced fluorescence; Complex luminescence

---

\*Corresponding author. E-mail: lihl@lzu.edu.cn

## INTRODUCTION

Photo-properties of rare earth ions doped in alumina film which was prepared by sol-gel method, have been reported<sup>1</sup>, but that based on porous anodic alumina (AAO) are rarely detailed. An anodic oxide film formed on aluminum can emit visible light, i.e., photoluminescence (PL) when illuminated with UV radiation<sup>2</sup>. Zhang et al. found that photoluminescence of porous alumina film prepared in  $C_2H_2O_4$  and  $H_2SO_4$  increased with increasing heat-treatment temperature<sup>3</sup>. Meanwhile, the optical properties of rare earth ions have become recent areas of research because of their potential for utilization in optical memory chips<sup>4</sup>, and solid-state lasers<sup>5</sup>. However, no reports about photoluminescence of  $Eu^{3+}$ -AAO have been published.

In this letter, the enhanced fluorescence of Eu(III)-anchored porous anodic alumina film was observed and the luminescence mechanisms were discussed. Eu(III) acetylacetonate was grafted on porous anodic alumina by self-assembling. We investigated its formation and confirmed its presence by XPS.

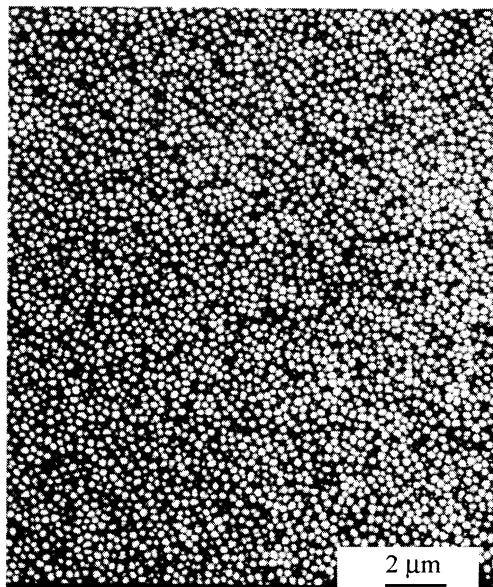
## EXPERIMENTAL

The anodizing of the Al plate (99.999% aluminum, dimensions of  $30 \times 10$  mm) was carried out at a constant voltage of 80 V in a 0.5 mol/L phosphoric acid bath at room temperature for 30 min, to obtain AAO film with the average pore size of 100 nm. The morphology of the porous anodic alumina membrane was observed using Transmission Electron Microscopic (TEM) image recorded with a Hitachi-600 microscope (Fig. 1). The porous anodic alumina, with aluminum, was immersed in an aqueous solution of 0.1 mol/L europium acetylacetonate for 6 h and 24 h at room temperature, separately. Then they were sonicated and washed with deionized water and absolute ethanol several times to remove physical adsorption of europium acetylacetonate.

X-ray Photoelectron Spectroscopy (XPS) (V.G. ESCA Lab 220I-XL photoelectron spectrometer, Al  $K_{\alpha}$  source) was used to confirm the presence of Eu(III) in the Eu(III)-anchored alumina. The fluorescence spectra were measured using a Hitachi M-850 fluorescence spectrophotometer. The light source for excitation was from a 150 W Xe lamp. The emitted light was detected with an R3788 photomultiplier tube with a set resolution of 1.0 nm.

## RESULTS AND DISCUSSION

The anchoring of europium(III) acetylacetonate on the porous alumina support was accomplished via the replacement of the ligand (L) by a



**Figure 1.** TEM image of porous anodic alumina film.

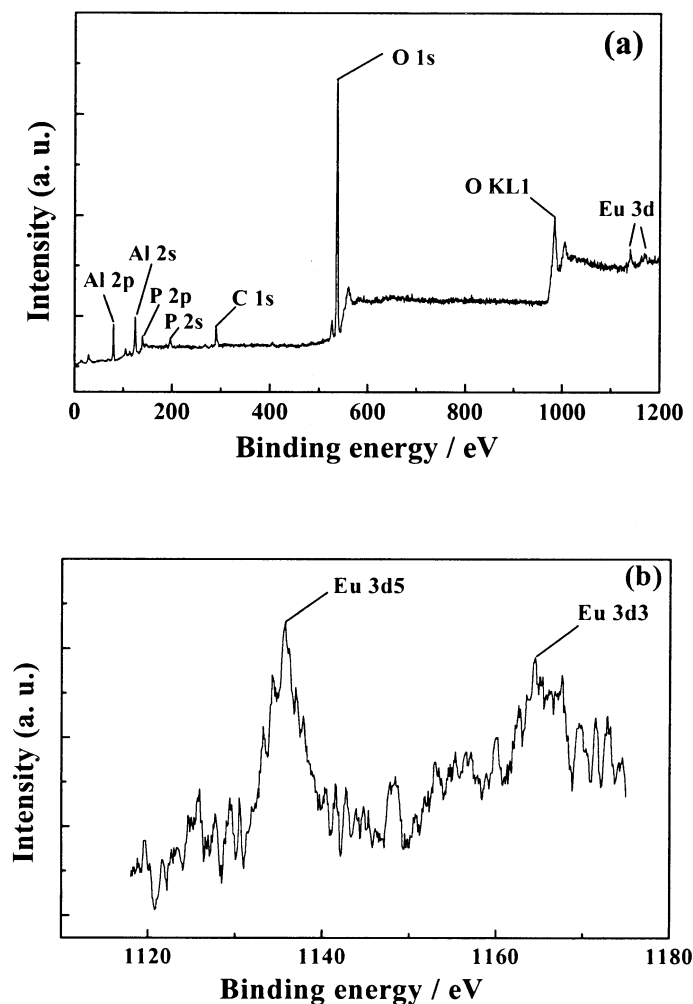
surface proton, which reciprocates by forming a stable molecule with the anion. This process facilitates ligand removal and is accompanied by the introduction of surface  $\text{—O—M}$  ( $\text{M} = \text{Al, Si, ...}$ ) in the metal complex according to<sup>6</sup>



It is found that the europium(III) ions are preferentially coordinated with Al—O polyhedral and the covalence of the Eu—O bond is decreased by the coordinated  $\text{Al}^{3+}$  ions<sup>7</sup>.

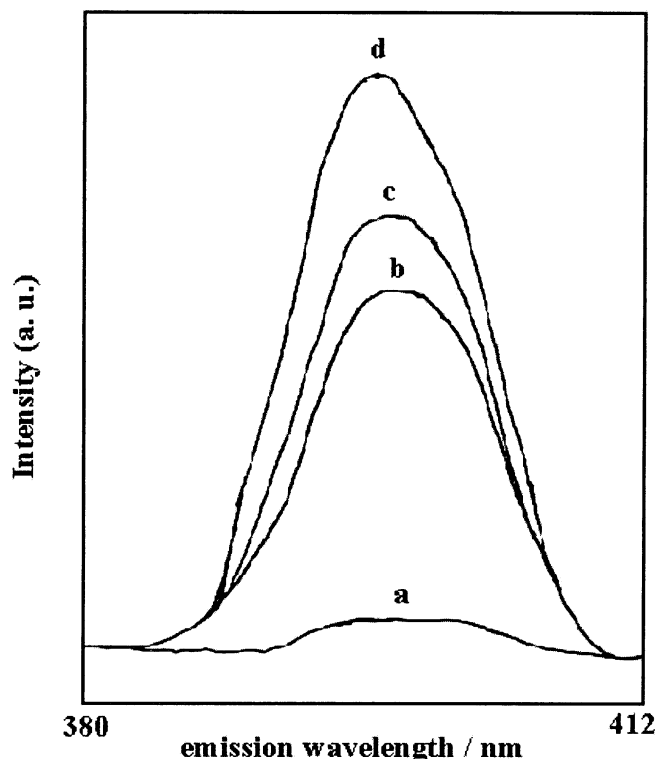
Figure 2a shows the XPS survey spectrum for the  $\text{Eu}^{3+}$ -anchored alumina which exhibits the characteristic O1s (531 eV), Al 2s (119 eV) and Al 2p (74 eV) peaks associated to the AAO film. The peaks of P 2s (191 eV) and P 2p (133 eV) originate from the  $\text{PO}_4^{3-}$  ions incorporated into the AAO film during the anodic oxidation. The peaks of C1s (285 eV), Eu 3d5 (1136 eV) and Eu 3d3 (1166 eV) are due to the anchoring of Europium(III). The Eu 3d5 (1136 eV) and Eu 3d3 (1166 eV) level spectrum is shown in Figure 2b.

In Figure 3, the photoluminescence (PL) spectrum of the AAO film displays a narrow blue-green emission centered at 397 nm. PL in this



**Figure 2.** The XPS spectra of the Eu(III)-anchored porous alumina (AAO) film a) the XPS survey spectrum; b) the Eu 3d level spectrum.

spectral region is attributed to the presence of oxygen vacancies associated with electrons localized on the bridge oxygen atoms in the lattice. This emission results from the recombination of photogenerated charge carriers in shallow traps. From the PL spectra, it can also be seen that the AAO film derived from  $\text{H}_3\text{PO}_4$  shows a stronger fluorescence than the film prepared in  $\text{H}_2\text{SO}_4$  and exhibits a blue shift band. This enhancement may



**Figure 3.** The photoluminescence spectra of the porous alumina film derived from 0.5 mol/L  $\text{H}_2\text{SO}_4$  (a); derived from 0.5 mol/L  $\text{H}_3\text{PO}_4$  (b); the Eu(III)-anchored porous alumina for 6 h (c); 24 h (d) ( $\lambda_{\text{ex}} = 310 \text{ nm}$ ).

be attributed to the incorporation of  $\text{PO}_4^{3-}$  except for the existence of many singly ionized oxygen vacancies ( $\text{F}^+$  centers) during the anodic proceeding<sup>3</sup>.

Figure 2 also presents Eu(III)-anchored porous anodic alumina film in the wavelength range of 380 ~ 412 nm. Clearly, the intensity of the PL band of Eu(III)-anchored porous alumina further increases in comparison with the unanchored alumina. Moreover, it was noticed that the longer anchoring time, the more enhanced PL intensity due to the more Eu(III) anchored. No emission that corresponds to  $^5\text{D}_0\text{-}^7\text{F}_j$  where  $j = 0, 1, 2, 3, 4$  and displays in wavelengths from 580 to 700 nm was found even if excited at 394 nm, which confirms the absence of  $\text{Eu}^{3+}$ . Then Eu must exist at its +2 valence during luminescing<sup>8</sup>.

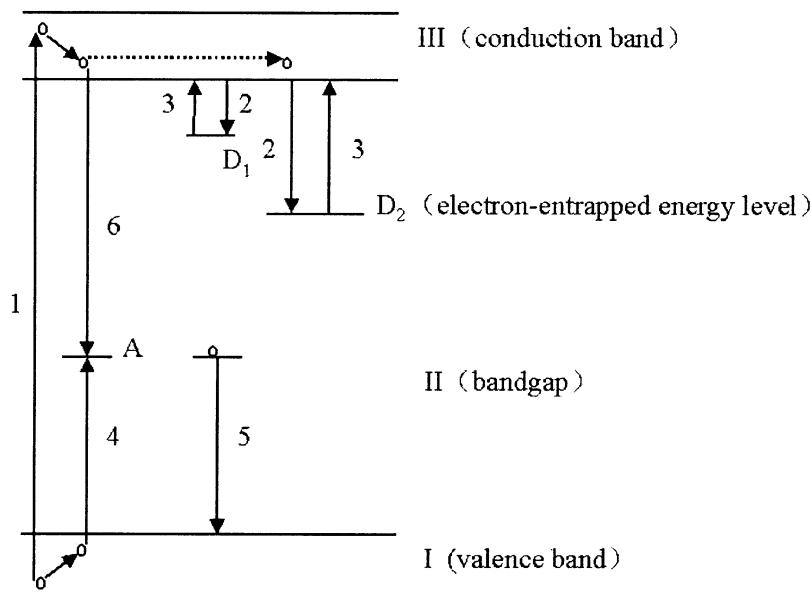


Figure 4. The Schon-Klasens model.

Due to the singly ionized oxygen vacancies in  $\text{AAO}^3$ , there would be  $e^-$ - $h^+$  pairs when the sample was excited by UV light<sup>9</sup>. The defects or ejected electrons that stem from these carriers are free to move about and can be effectively harvested for the reduction of high oxidation states rare-earth metal ions to their corresponding low oxidation state ions. When  $\text{Eu}^{3+}$  is grafted on AAO, the ejected electrons from the oxygen-associated hole centers react with  $\text{Eu}^{3+}$  to produce  $\text{Eu}^{2+}$  ions, which have been proposed to become stable by forming  $\text{Eu}^{2+}$ -hole complex<sup>10</sup>. The outer electrons of  $\text{Eu}^{2+}$  were strongly affected by their surrounding field, so that they can enter the conduction band and take part in photoconduction. The luminescence spectra were not determined by energy structure of  $\text{Eu}^{2+}$ , but by property of the whole complex, which was called complex luminescence. Photoluminescence was caused by electron-hole through luminescence center. The phenomenon can be well illustrated by Schon-Klasens model (Fig. 3)<sup>8</sup>.

Electrons and holes in porous anodic alumina can freely move about in the energy band to produce photoconduction (process 1). A small amount of  $\text{Eu}^{2+}$  engendered an impurity center in the forbidden band, i.e., luminescence A. Because of thermodynamic equilibrium, electrons soon were

reduced to the bottom of conduction band, reversibly, holes to the top. Electrons can be effectively harvested by the electron trap D (process 2) when diffusing in conduction band, and they would not be released until they accepted energy (from infrared light or by heat-treatment) (process 3). On the other hand, holes can be trapped by unionized luminescence center A (process 4), and they may return to conduction band due to thermo-disturbance (process 5). Luminescence was caused by multiplex of conduction band electrons and holes on luminescence center A (process 6). Therefore, AAO played a major role. As we can see, the shape and emission wavelength of  $\text{Eu}^{3+}$ -AAO luminescence band was similar to that of AAO. A stronger intensity was caused by  $\text{Eu}^{2+}$ . However, the luminescence mechanisms were not different at all.

In conclusion, the enhanced luminescence of  $\text{Eu}^{3+}$ -anchored porous anodic alumina is attributed to the multiplex luminescence.

## REFERENCES

1. Kurokawa, Y.; Ishizaka, T.; Ikoma, T.; Tero-Kubota, S. Photo-Properties of Rare Earth Ion( $\text{Er}^{3+}$ ,  $\text{Eu}^{3+}$  and  $\text{Sm}^{3+}$ )-Doped Alumina Films Prepared by the Sol-Gel Method. *Chem. Phys. Lett.* **1998**, 287, 737–741.
2. Tajima, S.; Baba, N.; Shimizu, K.; Mizuki, I. Photoluminescence of Anodic Oxide Films on Aluminum. *Electrocomp. Sci. Technol.* **1976**, 2, 91–95.
3. Du, Y.; Cai, W.L.; Mo, C.M.; Chen, J.; Zhang, L.D.; Zhu, X.G. Preparation and Photoluminescence of Alumina Membranes with Ordered Pore Arrays. *Appl. Phys. Lett.* **1999**, 74, 2951–2953.
4. Satio, M.; Kumagai, M.; Miyagi, M.; Wada, K. Optical Loss Distribution in Anodically Oxidized Alumina with a 2-D Structure. *Appl. Opt.* **1991**, 30, 2257–2262.
5. Hass, G.J. On the Preparation of Hard Oxide Films with Precisely Controlled Thickness on Evaporated Aluminum Mirrors. *Opt. Soc. Am.* **1949**, 39, 532–546.
6. Molina, R.; Poncelet, G.  $\alpha$ -Alumina-Supported Nickel Catalysts Prepared with Nickel Acetylacetonate.2. A Study of the Thermolysis of the Metal Precursor. *J. Phys. Chem. B* **1999**, 103, 11290–11296.
7. Nogami, M.; Abe, Y. Enhanced Emission from  $\text{Eu}^{2+}$  Ions in Sol-Gel Derived  $\text{Al}_2\text{O}_3$ - $\text{SiO}_2$  Glasses. *Appl. Phys. Lett.* **1996**, 25, 3776–3778.
8. Liu, Z.W. *Modern Inorganic Synthesis*, 1st ed. Peking: Chemistry and Technology Publisher, 1999.



9. Cui, X.S. *Solid Chemistry Foundation*, 1st ed. Peking: Peking Science and Technology Uni.; 1991.
10. Zaitoun, M.A.; Kim, T.; Lin, C.T. Observation of Electron-Hole Carrier Emission in the  $\text{Eu}^{3+}$ -Doped Silica Xerogel. *J. Phys. Chem. B* **1998**, *102*, 1122–1125.

Received December 16, 2000

Accepted March 15, 2001